April 2013



FGAF20N60SMD 600 V, 20 A Field Stop IGBT

Features

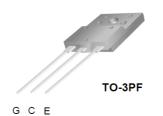
- Maximum Junction Temperature : T_J = 175°C
- Positive Temperaure Co-efficient for easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: V_{CE(sat)} = 1.7 V(Typ.) @ I_C = 20 A
- High Input Impedance
- Fast Swiching: E_{OFF} = 7 uJ/A
- Tightened Parameter Distribution
- RoHS Compliant

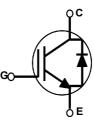
Applications

- Sewing Machine, CNC
- Home Appliances, Motor-Control

General Description

Using novel field stop IGBT technology, Fairchild[®]'s new series of field stop 2nd generation IGBTs offer the optimum performance for solar inverter, UPS, welder and PFC applications where low conduction and switching losses are essential.





Absolute Maximum Ratings

Symbol	Description		Ratings	Unit	
V _{CES}	Collector to Emitter Voltage		600	V	
V _{GES}	Gate to Emitter Voltage		± 20	V	
I _C	Collector Current	@ T _C = 25°C	40	A	
·C	Collector Current	@ T _C = 100 ^o C	20	A	
I _{CM (1)}	Pulsed Collector Current		60	A	
I _F	Diode Forward Current	@ T _C = 25°C	20	A	
	Diode Forward Current	@ T _C = 100 ^o C	10	A	
I _{FM (1)}	Pulsed Diode Maximum Forward Current		60	A	
P _D	Maximum Power Dissipation	@ T _C = 25°C	62.5	W	
· D	Maximum Power Dissipation	@ T _C = 100°C	31.3	W	
TJ	Operating Junction Temperature		-55 to +175	°C	
T _{stg}	Storage Temperature Range		-55 to +175	°C	
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds	300	°C		

Notes:

1: Repetitive rating: Pulse width limited by max. junction temperature

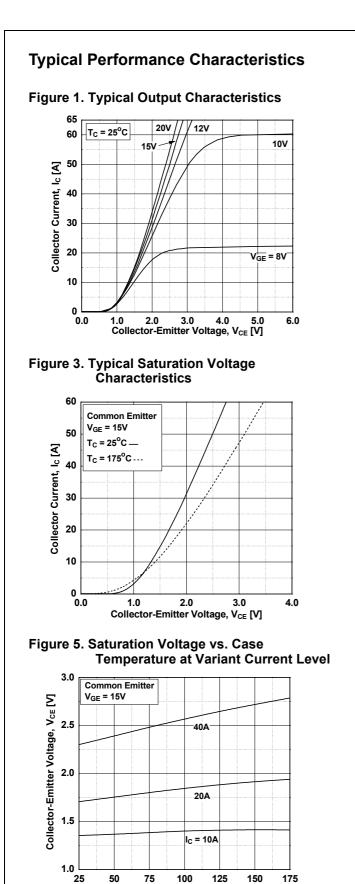
Symbol		Para	r	Тур.		p.	Max.	Unit			
R _{θJC} (IGBT)	T) Thermal Resistance, Junction to Ca			ise		-		2.0	°C/W		
R _{0JC} (Diode) Thermal Resistance, Junction to Ca			se -		4.0		°C/W				
R _{θJA}	Ther	mal Resistance, Junctio	on to An	nbient		-	- 40		°C/W		
Package	Mark	ing and Orderi	ng In	formatio	n						
Device Ma	rking	Device	Pa	ckage Reel Size		Таре	Tape Width		Quantity		
FGAF20N60	SMD	FGAF20N60SMD	٦	03-PF	-			-		30	
Electrical	Cha	racteristics of	the IC	GBT T _C = 25	°C unless othe	erwise noted					
Symbol		Parameter		Test	Test Conditions		Min.	Тур.	Max.	Unit	
Off Character	iatiaa						•				
Off Character BV _{CES} C		to Emitter Breakdown V	/oltage	$V_{CE} = 0V_{c}I_{C}$	= 250µA		600	-	_	V	
∆BV _{CES} Te		ure Coefficient of Break	0	V_{GE} = 0V, I _C = 250µA V_{GE} = 0V, I _C = 250µA		-	0.62	-	V/ºC		
I _{CES} C	ollector	Cut-Off Current		V _{CE} = V _{CES} , V _{GE} = 0V		-	-	250	μA		
I _{GES} G	i-E Leak	age Current	V _{GE} = V _{GES} , V _{CE} = 0V			-	-	±400	nA		
On Character	istics										
	G-E Threshold Voltage			I _C = 250μA, V _{CE} = V _{GE}			3.5	4.7	6.0	V	
				I _C = 20A, V _{GE} = 15V		-	1.7	-	V		
V _{CE(sat)} C	Collector to Emitter Saturation Voltage		$I_{\rm C}$ = 20A, $V_{\rm GE}$ = 15V, $T_{\rm C}$ = 175°C		-	1.9	-	V			
Dynamic Cha	racteris	stics									
-		pacitance		V _{CE} = 30V, V _{GE} = 0V, f = 1MHz			-	925	-	pF	
	utput C	apacitance					-	89	-	pF	
	everse	Transfer Capacitance					-	30	-	pF	
Switching Ch	aractor	istics									
		Delay Time					-	12	_	ns	
	ise Time	9		-			-	22	-	ns	
	urn-Off	Delay Time		$V_{CC} = 400V, I_C = 20A, R_G = 10\Omega, V_{GE} = 15V, Inductive Load, T_C = 25$			-	91	-	ns	
u(0)	all Time	-				_	-	21	27	ns	
-	urn-On	Switching Loss				ъС	-	452	-	uJ	
	urn-Off :	Switching Loss					-	141	187	uJ	
	otal Swi	tching Loss					-	593	-	uJ	
		Delay Time					-	12	-	ns	
	ise Time	9		V _{CC} = 400V, I _C = 20A,			-	19	-	ns	
	urn-Off	Delay Time					-	93	-	ns	
	all Time			R _G = 10Ω, V	_{GE} = 15V,	-0	-	16	-	ns	
E _{on} T	urn-On	Switching Loss		Inductive Lo	ad, T _C = 17	5°C	-	667	-	uJ	
		Switching Loss		1			-	317	-	uJ	
		tching Loss		1			-	984	-	uJ	

Electrical Characteristics of the IGBT (Continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Unit
Qg	Total Gate Charge		-	64	-	nC
Q _{ge}	Gate to Emitter Charge	V _{CE} = 400V, I _C = 20A, V _{GE} = 15V	-	6.2	-	nC
Q _{gc}	Gate to Collector Charge	VGE - 15V	-	32	-	nC

Electrical Characteristics of the Diode T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Мах	Unit
V _{FM}	Diode Forward Voltage	I _F = 10A	T _C = 25°C	-	2.3	-	V
FM Diode i ciward voltage			T _C = 175 ^o C	-	1.67	-	
E _{rec}	Reverse Recovery Energy		T _C = 175 ^o C	-	13.8	-	uJ
t.	Diode Reverse Recovery Time	I _F =10A, dI _F /dt = 200A/μs	T _C = 25°C	-	26.7	-	ns
۲rr		$r_{\rm F} = 10$, $r_{\rm F}$ $r_{\rm C} = 200$ / μ s	T _C = 175 ^o C	-	88.2	-	110
Q _{rr}	Diode Reverse Recovery Charge		T _C = 25 ^o C	-	42	-	nC
~II.	block hover to be house house		T _C = 175 ^o C	-	245	-	



Collector-EmitterCase Temperature, T_C [°C]

Figure 2. Typical Output Characteristics

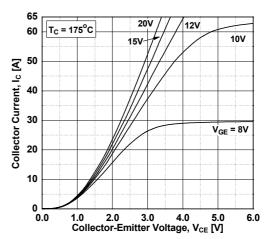


Figure 4. Transfer Characteristics

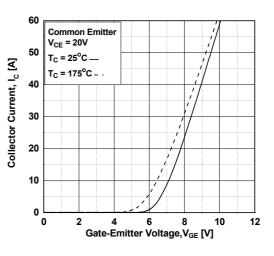
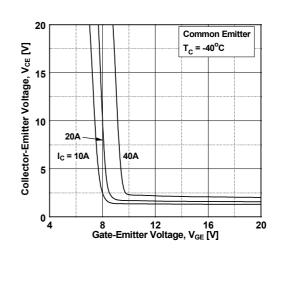


Figure 6. Saturation Voltage vs. V_{GE}



Typical Performance Characteristics

Figure 7. Saturation Voltage vs. V_{GE}

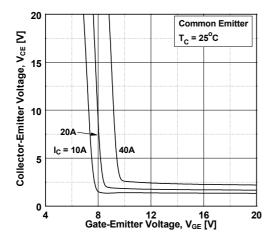


Figure 9. Capacitance Characteristics

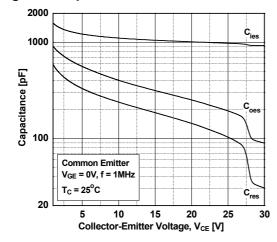


Figure 11. SOA Characteristics

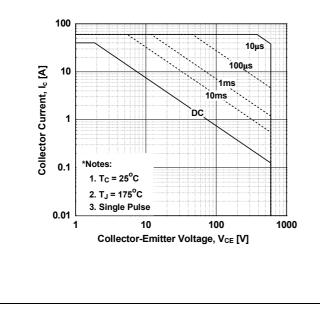


Figure 8. Saturation Voltage vs. V_{GE}

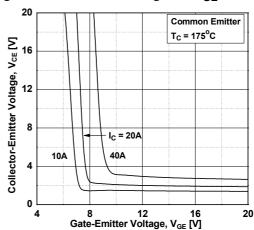


Figure 10. Gate charge Characteristics

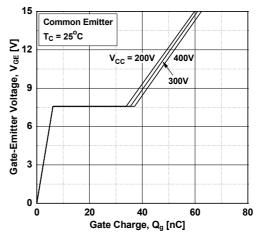
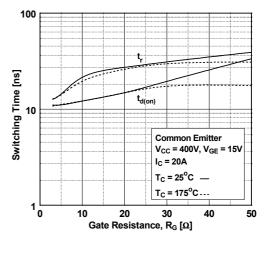


Figure 12. Turn-on Characteristics vs. Gate Resistance



FGAF20N60SMD 600 V 20 A Field Stop IGBT

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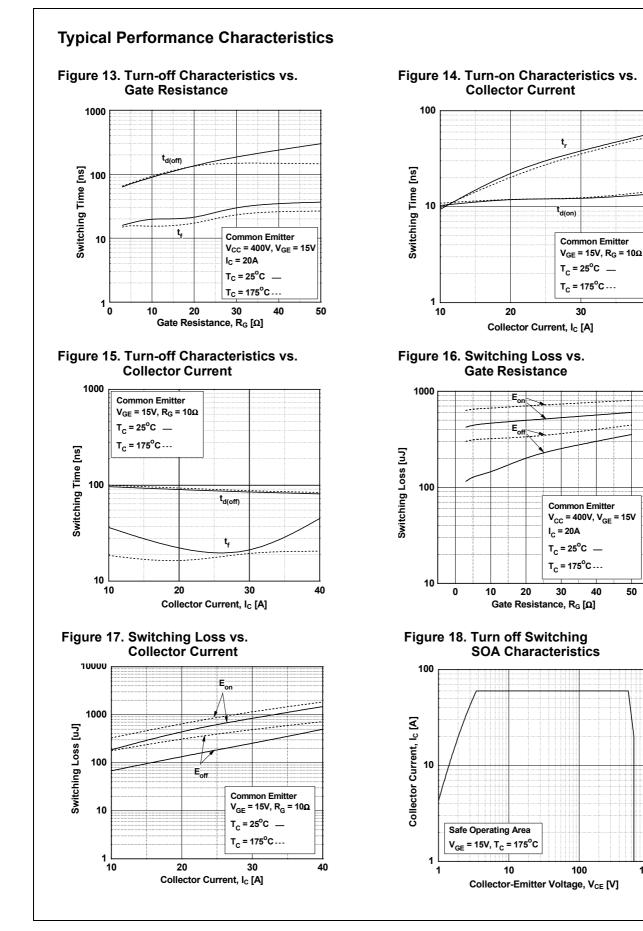
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175°C--

100

40

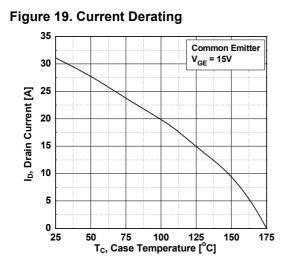
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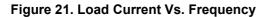


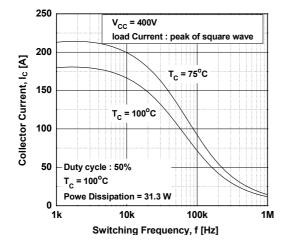
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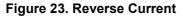
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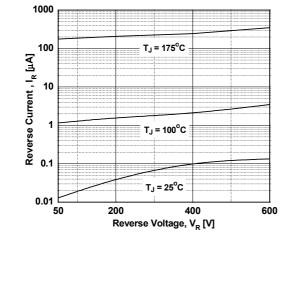
Typical Performance Characteristics



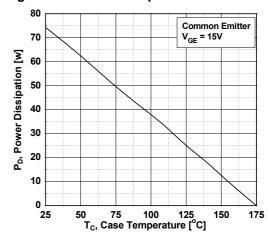




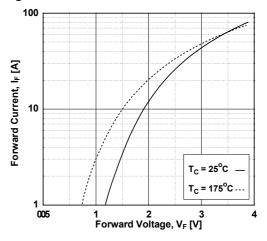




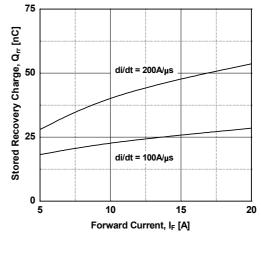


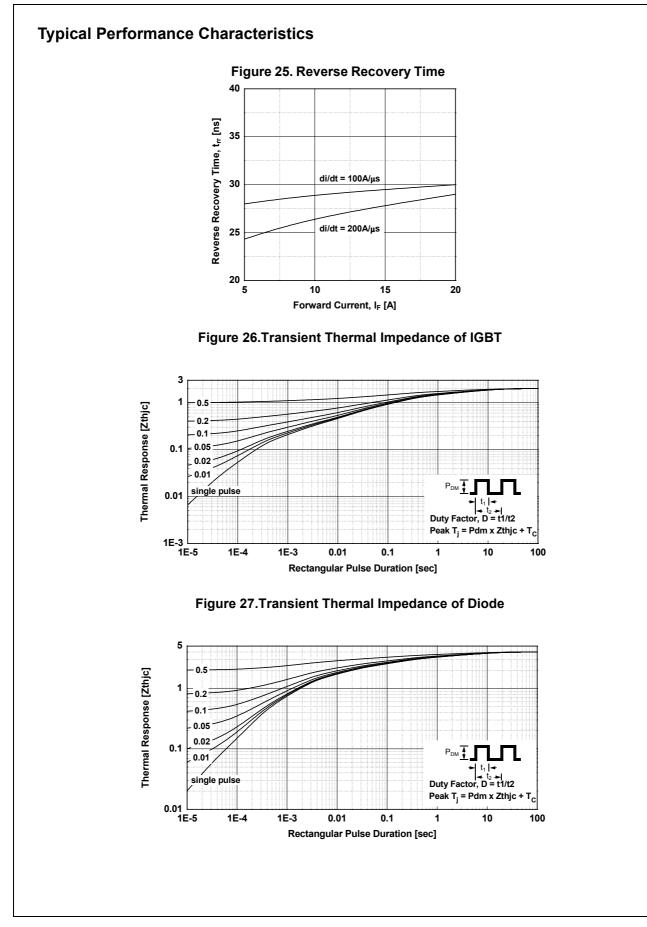


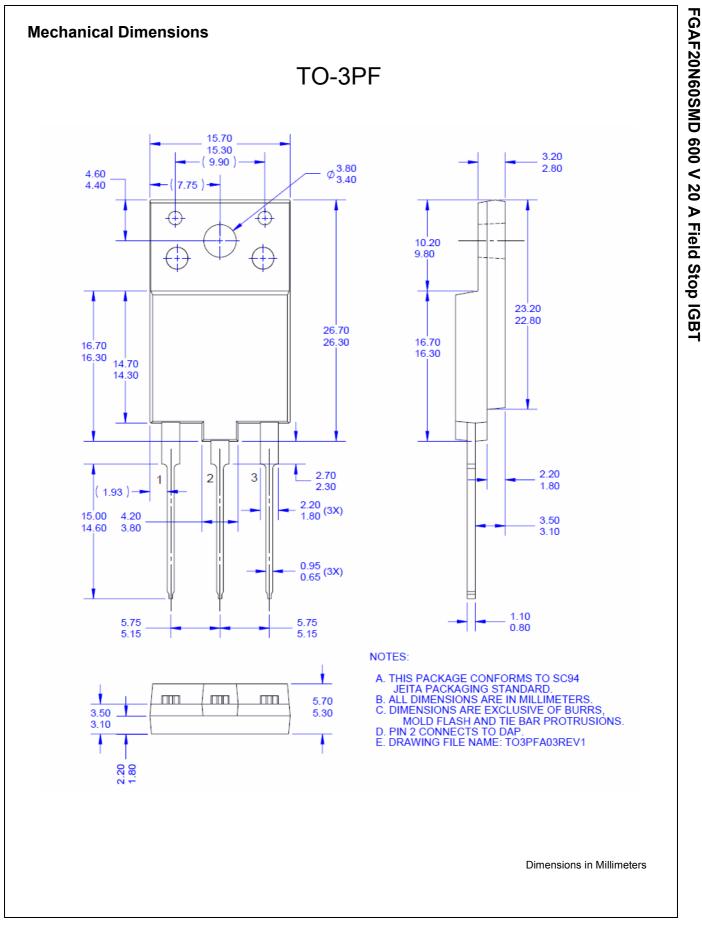














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